

COMPLIANT

2SK2608-VB Datasheet

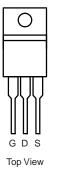
N-Channel 900V (D-S) Super Junction Power MOSFET

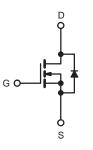
| PRODUCT SUMMARY | | | | | |
|----------------------------|----------------------------|----|--|--|--|
| V _{DS} (V) | 900 | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V 1.3 | | | | |
| Q _g (Max.) (nC) | 200 | | | | |
| Q _{gs} (nC) | 24 | | | | |
| Q _{gd} (nC) | 110 |) | | | |
| Configuration | Sing | le | | | |

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C | = 25 °C, unl | ess otherwis | se noted) | | | |
|---|-------------------------|-----------------------------------|-----------------|------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 900 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | I _D | 5 | | |
| Continuous Drain Current | VGS at 10 V | T _C = 100 °C | | 3.9 | A | |
| Pulsed Drain Current ^a | | • | I _{DM} | 21 | | |
| Linear Derating Factor | | | | 1.5 | W/°C | |
| Single Pulse Avalanche Energy ^b | | E _{AS} | 770 | mJ | | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 7.8 | A | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 19 | mJ | |
| Maximum Power Dissipation $T_{C} = 25 \text{ °C}$ | | PD | 190 | W | | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 2.0 | V/ns | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to + 150 | °C | | |
| Soldering Recommendations (Peak Temperature) | for | 10 s | | 300 ^d | 0 | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ∙ in | |
| Mounting Torque | | | | 1.1 | N · m | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 23 mH, $R_g = 25 \Omega$, $I_{AS} = 7.8$ A (see fig. 12). c. $I_{SD} \le 7.8$ A, dl/dt ≤ 140 A/µs, $V_{DD} \le 600$ V, $T_J \le 150$ °C. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

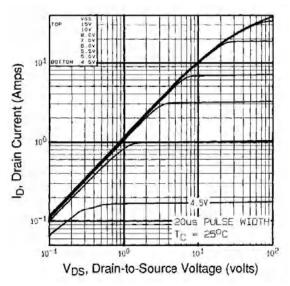
| 9 | 3 | ® V | Bs | emi |
|---|------|--------|-----|-------|
| W | ww.\ | /Bs | sem | i.com |

| THERMAL RESISTANCE RATII | NGS | | | | | | | | |
|---|------------------------|--|--|--|------------|-----------|----------|------|--|
| PARAMETER | SYMBOL | TYP. | | MAX. | | | UNIT | | |
| Maximum Junction-to-Ambient | R _{thJA} | - | | 40 | | | | | |
| Case-to-Sink, Flat, Greased Surface | R _{thCS} | 0.24 | | - | | | °C/W | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | | 0.65 | | | | | |
| | | | | | | | | | |
| SPECIFICATIONS ($T_J = 25 \text{ °C}$, u | | 1 | | | | | | | |
| PARAMETER | SYMBOL | TES | T CONDIT | IONS | MIN. | TYP. | MAX. | UNIT | |
| Static | | | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} | = 0 V, I _D = | 250 µA | 900 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | | | , I _D = 1 mA | - | 0.98 | - | V/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | $= V_{GS}, I_D =$ | 250 µA | 2.0 | - | 4.0 | V | |
| Gate-Source Leakage | I _{GSS} | | $V_{GS} = \pm 20$ | | - | - | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = | = 800 V, V _C | _{as} = 0 V | - | - | 100 | μA | |
| 2010 Gate Voltage Drain Garrone | ¹ DSS | V _{DS} = 640 \ | $V, V_{GS} = 0$ | V, T _J = 125 °C | - | - | 500 | μι | |
| Drain-Source On-State Resistance | R _{DS(on)} | $V_{GS} = 10 V$ | ار | _D = 3.7 A ^b | - | 1.3 | - | Ω | |
| Forward Transconductance | g _{fs} | V _{DS} = | = 100 V, I _D | = 3.7 A ^b | 5.6 | - | - | S | |
| Dynamic | | | | | | | | | |
| Input Capacitance | C _{iss} | | V _{GS} = 0 \ | 1 | - | 3100 | - | | |
| Output Capacitance | C _{oss} |] | $V_{DS} = 25$ | V, | - | 800 | - | pF | |
| Reverse Transfer Capacitance | C _{rss} | f – 10 MHz see fig 5 | | 490 | - | | | | |
| Total Gate Charge | Qg | | | | - | - | 200 | | |
| Gate-Source Charge | Q _{gs} | $V_{GS} = 10 V$ | | A, $V_{DS} = 400 V$, ig. 6 and 13 ^b | - | - | 24 | nC | |
| Gate-Drain Charge | Q _{gd} | | 3001 | ig. o and to | - | - | 110 | | |
| Turn-On Delay Time | t _{d(on)} | | | | - | 19 | - | | |
| Rise Time | tr | | = 400 V, I _D | | - | 38 | - | | |
| Turn-Off Delay Time | t _{d(off)} | R _g = | = 6.2 Ω, R _D see fig. 10 | = 52 Ω nb | - | 120 | - | ns | |
| Fall Time | t _f | - | see lig. It | | - | 39 | - | | |
| Internal Drain Inductance | L _D | Between lead 6 mm (0.25") 1 | | | - | 5.0 | - | | |
| Internal Source Inductance | L _S | package and die contact | center of | | - | 13 | - | nH | |
| Drain-Source Body Diode Characteristic | S | | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET sym showing the | bol | | - | - | 5.0 | А | |
| Pulsed Diode Forward Current ^a | I _{SM} | p - n junction diode | | 21 | | | | | |
| Body Diode Voltage | V _{SD} | T _J = 25 °C | C, I _S = 3.8 A | A, V _{GS} = 0 V ^b | - | - | 1.8 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | Т.= | 25 °C. I⊧ = | = 3.8 A. | - | 650 | 980 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | $T_J = 25 \text{ °C}, I_F = 3.8 \text{ A},$ $dI/dt = 100 \text{ A}/\mu\text{s}^{b}$ | | - | 3.8 | 5.7 | μC | | |
| Forward Turn-On Time | t _{on} | Intrinsic tu | rn-on time | is negligible (turn | -on is dor | ninated h | v Ls and | Ln) | |

Notes

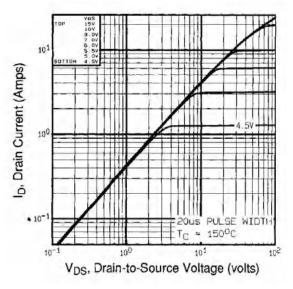
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







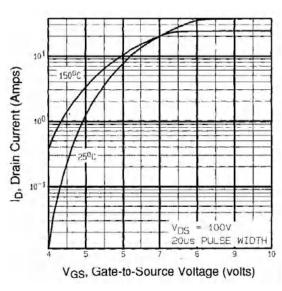
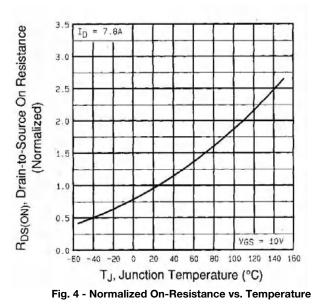


Fig. 3 - Typical Transfer Characteristics





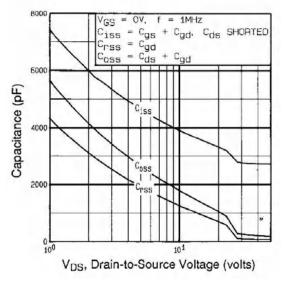


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

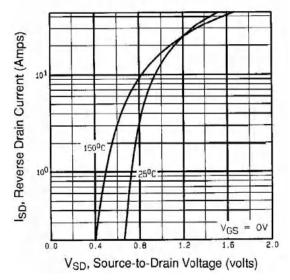


Fig. 7 - Typical Source-Drain Diode Forward Voltage

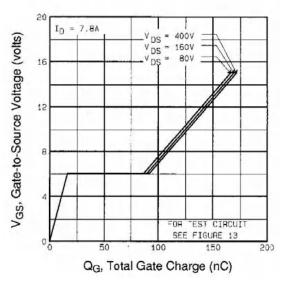
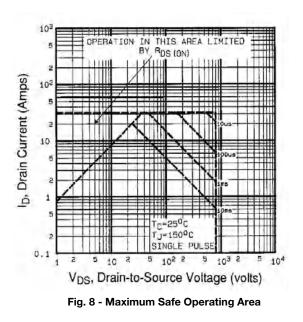


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



2SK2608-VB



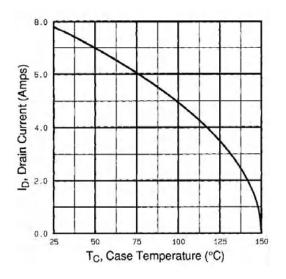


Fig. 9 - Maximum Drain Current vs. Case Temperature

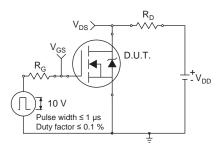


Fig. 10a - Switching Time Test Circuit

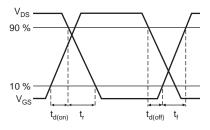


Fig. 10b - Switching Time Waveforms

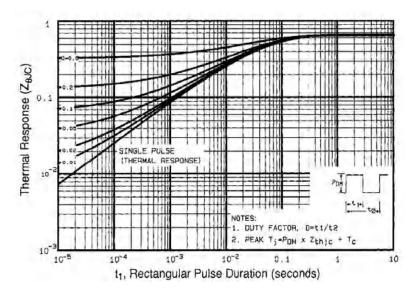


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



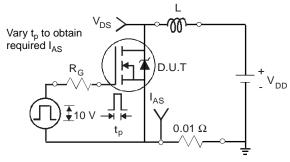


Fig. 12a - Unclamped Inductive Test Circuit

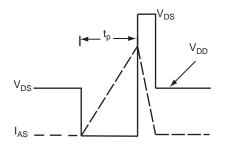


Fig. 12b - Unclamped Inductive Waveforms

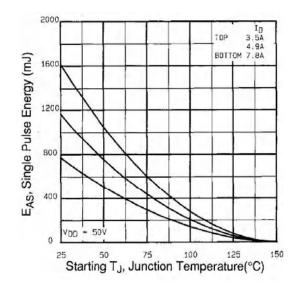


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



Fig. 13a - Basic Gate Charge Waveform

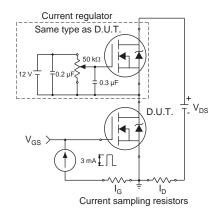
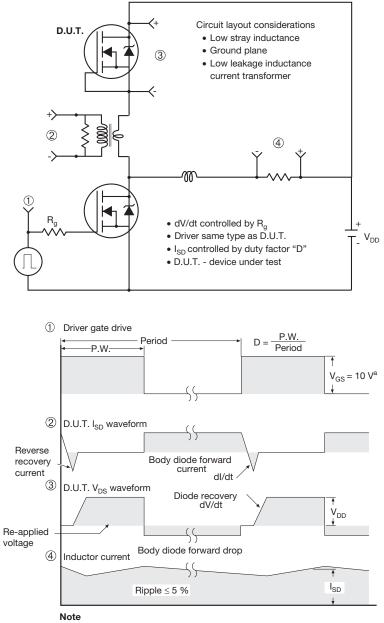


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

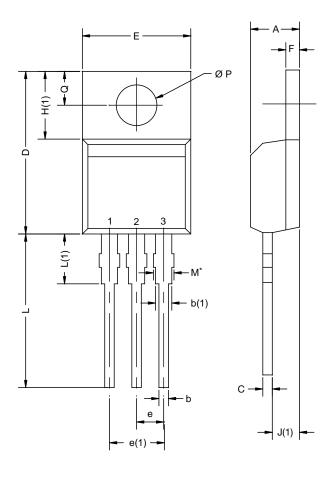


a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-220AB



| | MILLIN | IETERS | INC | HES | |
|-----------------------|-------------------|-----------|-------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | |
| Е | 10.04 | 10.51 | 0.395 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | |
| ØР | 3.54 | 3.94 | 0.139 | 0.155 | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | |
| ECN: X12- DWG: 547 | 0208-Rev. N, 1 | 08-Oct-12 | | | |

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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